

<b>Notice of References Cited</b>	Application/Control No. 09/986,771	Applicant(s)/Patent Under Reexamination NAKATSUKA ET AL.	
	Examiner Sunit Pandya	Art Unit 3714	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,076,584 A	12-1991	Openiano, Renato M.	463/36
*	B	US-6,227,968 B1	05-2001	Suzuki et al.	463/7
*	C	US-6,347,998 B1	02-2002	Yoshitomi et al.	463/42
*	D	US-6,369,313 B2	04-2002	Devecka, John R.	84/743
*	E	US-6,450,888 B1	09-2002	Takase et al.	463/43
*	F	US-6,582,309 B2	06-2003	Higurashi et al.	463/31
*	G	US-6,572,108 B1	06-2003	Bristow, Steve	273/148B
*	H	US-6,659,873 B1	12-2003	Kitano et al.	463/42
*	I	US-6,695,694 B2	02-2004	Ishikawa et al.	463/7
*	J	US-6,685,480 B2	02-2004	Nishimoto et al.	434/247
*	K	US-6,905,413 B1	06-2005	Terao et al.	463/40
*	L	US-7,128,649 B2	10-2006	Nobe et al.	463/23
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.